

<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/772,710	TEMLER ET AL.
Examiner	Art Unit	
MARK J. BEAUCHAINE	3653	

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner
<b>See</b>	<b>attached.</b>	5/1/2008	<b>MJB</b>